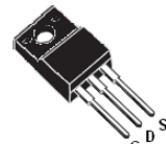


700V N-Channel Super Junction power MOSFET

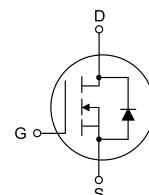
DESCRIPTION

SJ MOSFET is an advanced technology for high voltage power MOSFETs, designed according to the super junction principle by P&S. The offered devices provide all benefits of a fast switching and low on resistance, making it especially suitable for applications which require more efficient, more compact, LED Lighting, High Performance Adapter etc..

V_{DS}	700	V
R_{DS(ON)}	400	mΩ
I_D	15	A



TO-220F



Features

- Extremely low losses due to very low $R_{ds(on)} * Q_g$
- Superior Avalanche Rugged Technology
- Fast switching capability
- 100% Avalanche Tested
- Pb-free lead plating; ROHS compliant

APPLICATIONS

- Power factor correction (PFC)
- Switched mode power supplies(SMPS)
- Uninterruptible Power Supply (UPS)
- High Performance Adapter
- LED Lighting Power

ORDERING INFORMATION

Temperature Range	Package	Orderable Device	Package Qty.
-55°C ~ +125°C	TO-220F	Pb-Free	50 PCS/Tube

ABSOLUTE MAXIMUM RATINGS(T_j=25°C, unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage (V _{GS} =0V)	V _{DSS}	700	V
Gate-Source Voltage (V _{DS} =0V, static)	V _{GS}	±30	V
Continuous Drain Current (T _C =25 °C)(Note 1)	I _{D(DC)}	15	A
Continuous Drain Current (T _C =100 °C) (Note 1)	I _{D(DC)}	10	A
Pulsed Drain Current (Note 2)	I _{DM}	45	A
MOSFET dv/dt ruggedness, V _{DS} ≤480 V	dv/dt	50	V/nS
Single Pulsed Avalanche Energy (Note 3)	E _{AS}	400	mJ
Avalanche Energy, Repetitive (Note 1)	E _{AR}	0.7	mJ
Avalanche Current, Repetitive (Note 1)	I _{AR}	7.5	A
Maximum Power Dissipation (T _C =25 °C)	P _D	33	W
Operating, Storage Temperature Range	T _J , T _{STG}	-55~150	°C

THERMAL CHARACTERISTICS

Parameter	Symbol	Min.	Typ.	Max.	Units
Thermal Resistance, Junction-to-Case	R _{thJC}	-	-	3.8	°C /W
Thermal Resistance, Junction-to-Ambient	R _{thJA}	-	-	80	°C /W

ELECTRICAL CHARACTERISTICS(T_j = 25°C, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	TYP.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	700	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =700V, V _{GS} =0V	-	-	1	μA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±30V, V _{DS} =0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	2.5	3.0	3.5	V
Drain-Source On-state Resistance	R _{DS(on)}	V _{GS} =10V, I _D =7.5A	-	0.32	0.4	Ω
Gate Resistance	R _g	F=1MHZ, open drain	-	10.3	-	Ω



Dynamic Characteristics

($T_j = 25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Input capacitance	C_{iss}	$V_{DS}=100\text{V}$, $V_{GS}=0\text{V}$, $f=1\text{MHz}$	-	1036	-	pF
Output capacitance	C_{oss}		-	44.2	-	
Reverse transfer capacitance	C_{rss}		-	2.16	-	
Turn-on delay Time	$t_{d(on)}$	$V_{DD}=480\text{V}$, $I_D=15\text{A}$ $R_G=6.8\Omega$, $V_{GS}=10\text{V}$	-	26		ns
Rise time	t_r		-	34	-	
Turn-off delay time	$t_{d(off)}$		-	109		
Fall time	t_f		-	36		

Gate charge characteristics

($T_j = 25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Gate to Source Charge	Q_{gs}	$V_{DD}=480\text{V}$, $I_D=15\text{A}$ $V_{GS}=0$ to 10V	-	5.0	-	nC
Gate to Drain Charge	Q_{gd}		-	8.4	-	
Gate Charge Total	Q_g		-	24	-	
Gate Plateau Voltage	$V_{plateau}$		-	4.4	-	V

Reverse diode characteristics

($T_j = 25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Body Diode Forward Voltage	V_{SD}	$V_{GS}=0\text{V}$, $I_{SD}=15\text{A}$	-	0.9	-	V
Reverse Recovery Time	t_{rr}	$V_R=480\text{V}$, $I_F=15\text{A}$ $dI_F/dt=100\text{A}/\mu\text{s}$	-	270	-	nS
Reverse Recovery Charge	Q_{rr}		-	4.1	-	μC
Peak Reverse Recovery Current	I_{rrm}		-	22.8	-	A

Notes:

1. Limited by maximum junction temperature;
2. Pulse width limited by maximum junction temperature;
3. $I_{AS} = 9 \text{ A}$, $V_{DD} = 50 \text{ V}$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ\text{C}$.



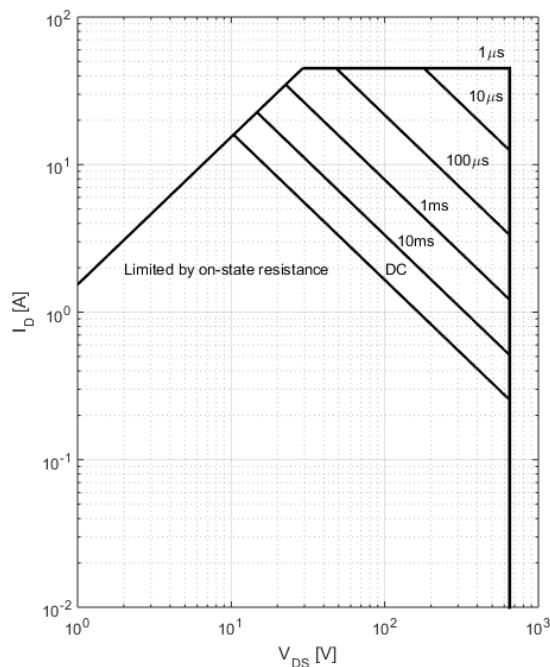
Apr. 2018

Rev 1.10

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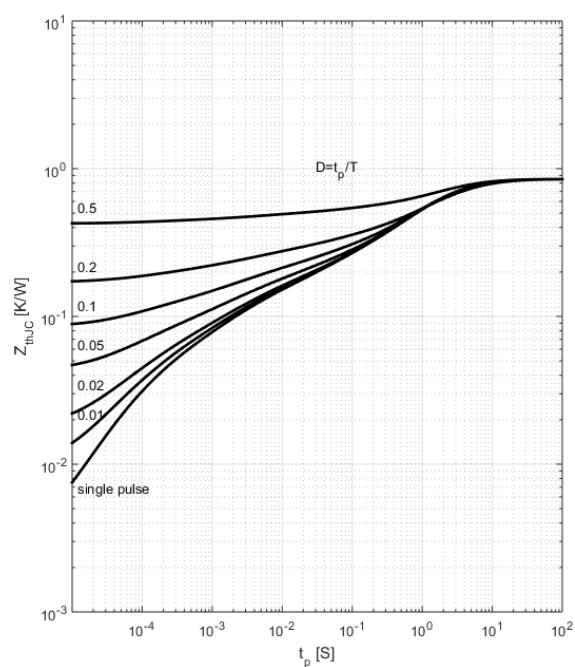
ELECTRICAL CHARACTERISTICS DIAGRAMS

Figure 1. Safe operating area



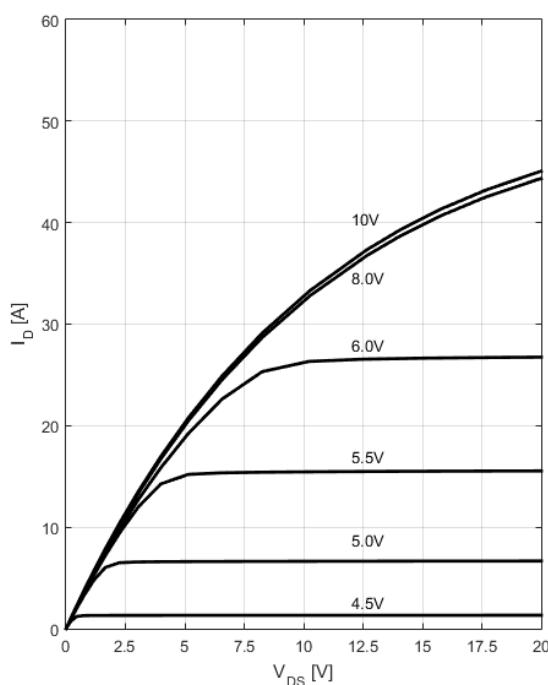
$I_D=f(V_{DS})$; $T_c=25\text{ }^\circ\text{C}$; parameter t_p

Figure 2. Transient thermal impedance



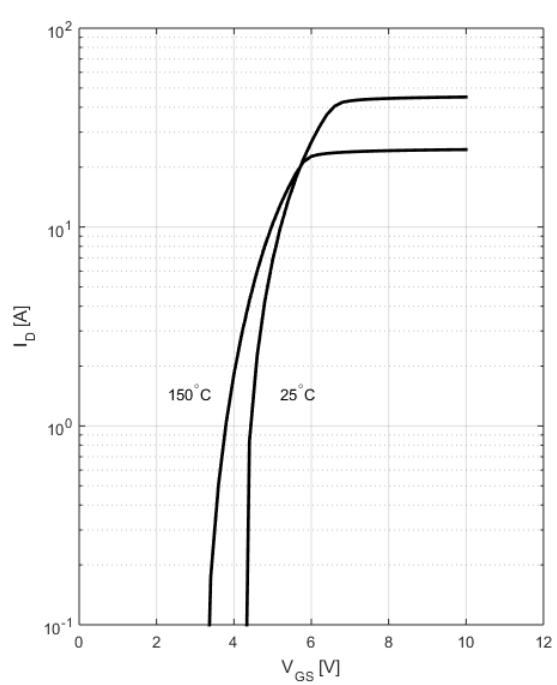
$Z_{(thJC)}=f(t_p)$; parameter: $D=t_p/T$

Figure 3. Typ. output characteristics



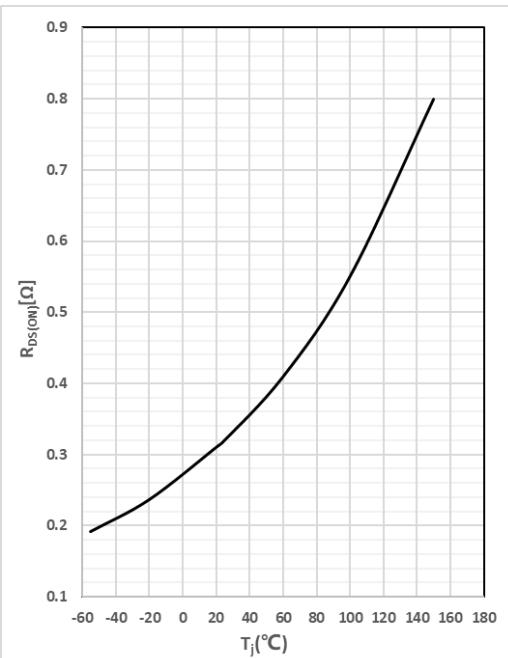
$I_D=f(V_{DS})$; $T_j=25\text{ }^\circ\text{C}$; parameter: V_{GS}

Figure 4. Typ. transfer characteristics



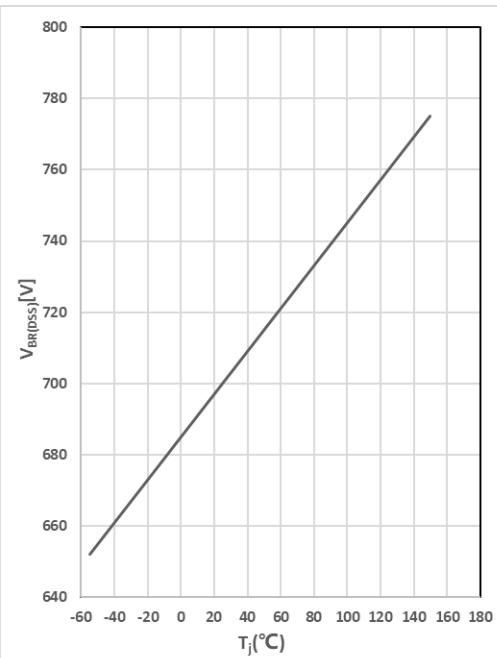
$I_D=f(V_{GS})$; $V_{DS}=20\text{V}$

Figure 5. Drain-source on-state resistance



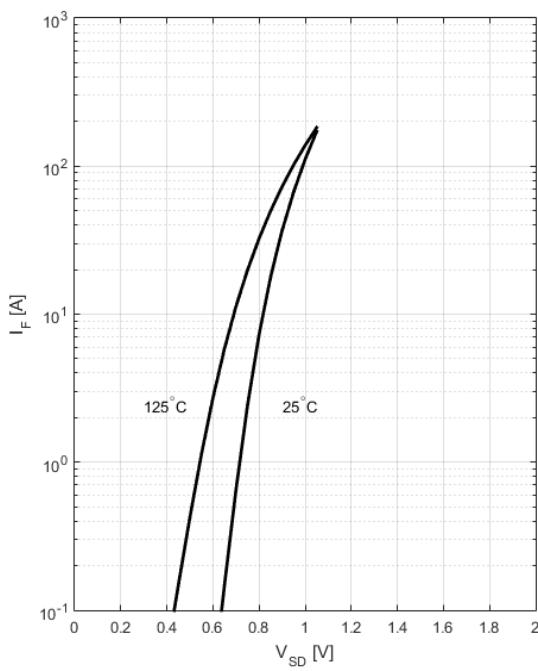
$$R_{DS(ON)} = f(T_j); I_D = 15\text{A}; V_{GS} = 10\text{V}$$

Figure 6. Drain-source breakdown voltage



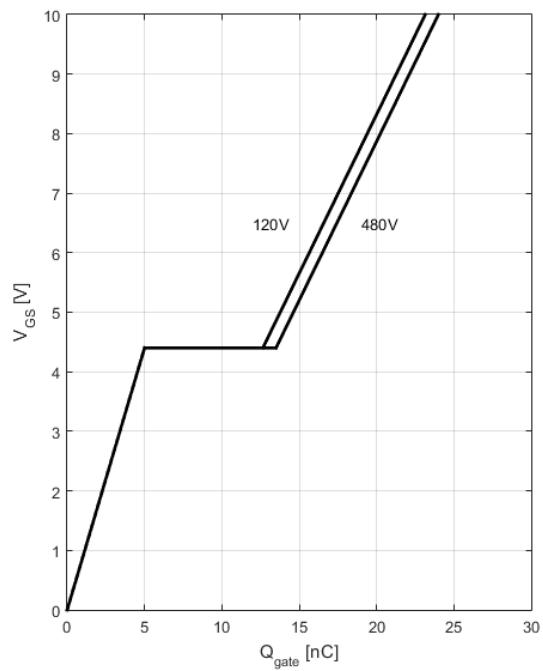
$$V_{BR(DSS)} = f(T_j); I_D = 10\text{mA}$$

Figure 7. Forward characteristics of reverse diode



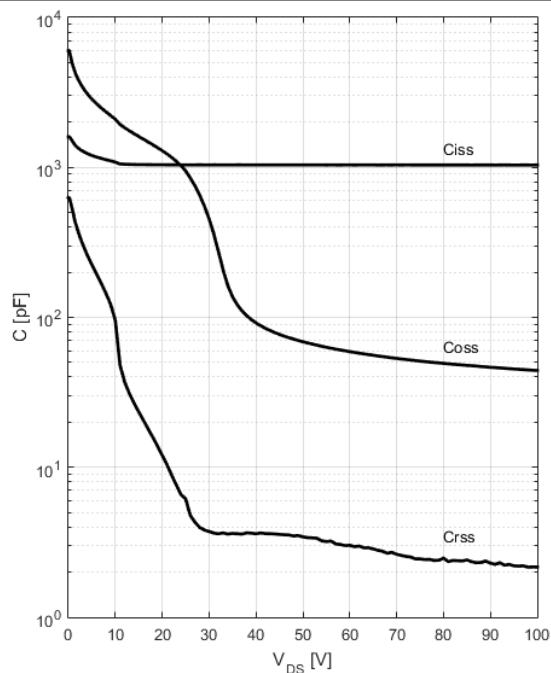
$$I_F = f(V_{SD}); \text{ parameter: } T_j$$

Figure 8. Typ. gate charge



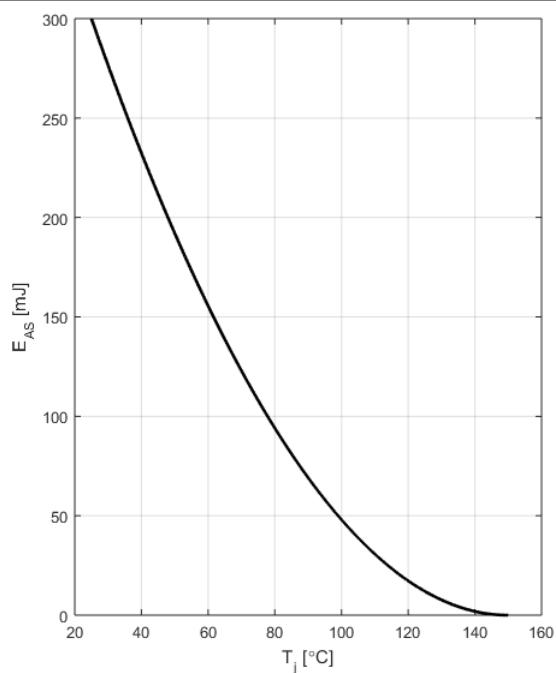
$$V_{GS} = f(Q_{gate}), I_D = 15\text{A pulsed}$$

Figure 9: Typ. capacitances



$C=f(V_{DS})$; $V_{GS}=0$; $f=1\text{MHz}$

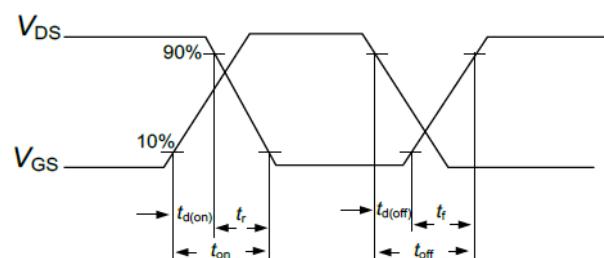
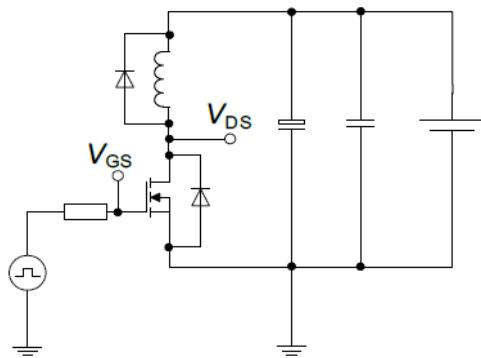
Figure 10: Avalanche energy



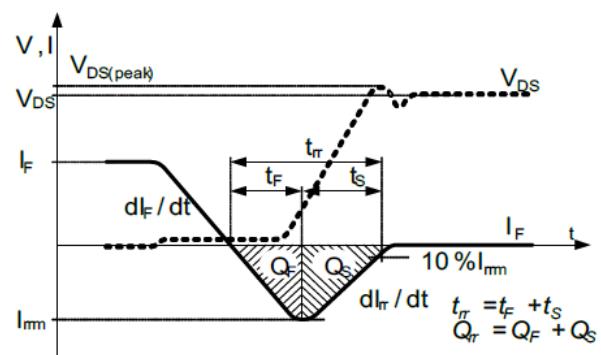
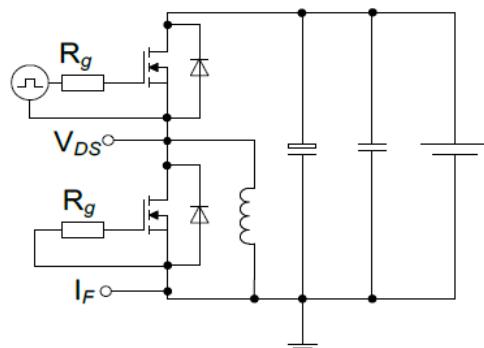
$E_{AS}=f(T_J)$; $I_D=7.5\text{A}$; $V_{DD}=50\text{V}$

Test Circuits

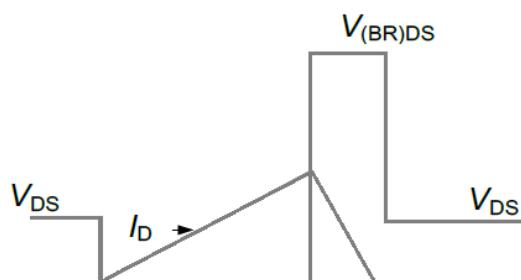
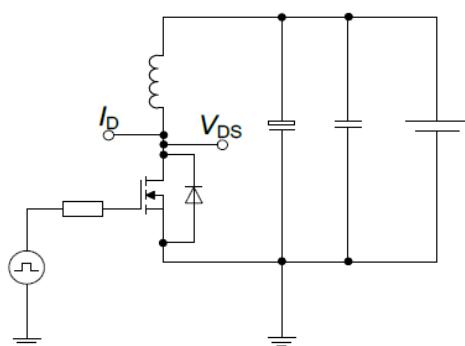
Switch time test circuit



Reverse diode characteristics test circuit and waveform

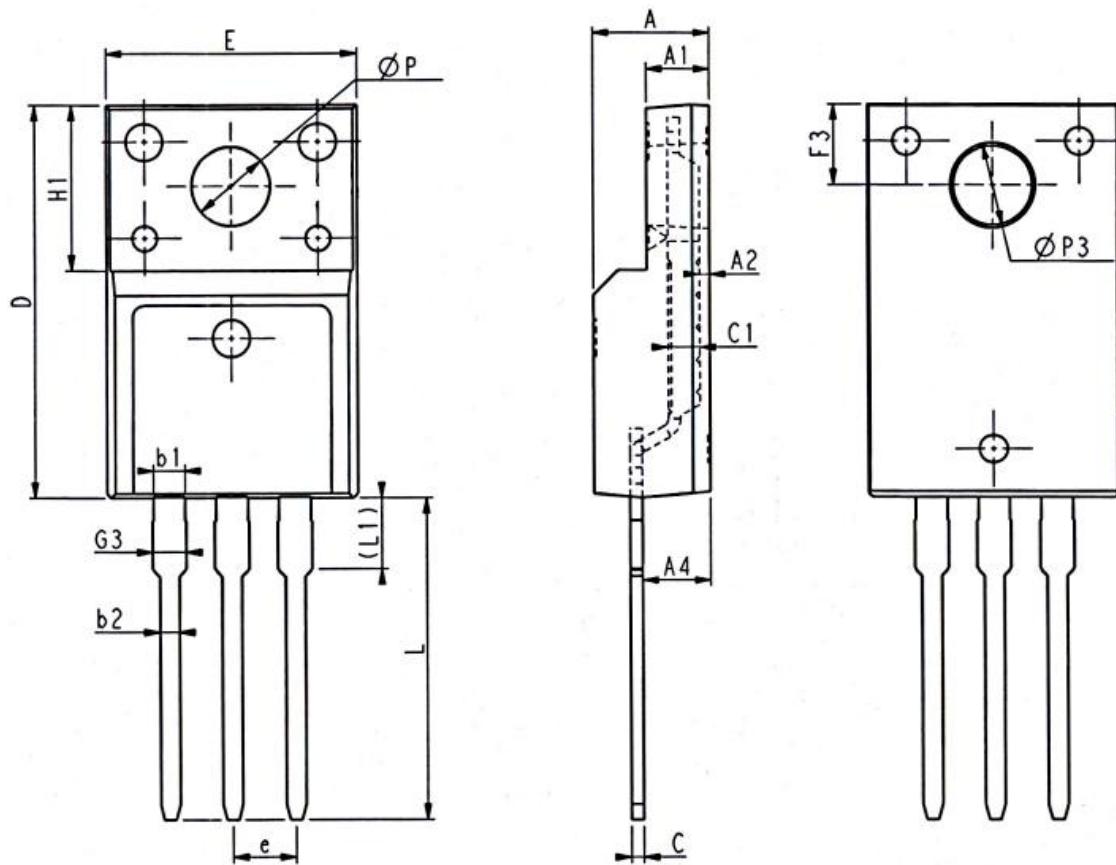


Unclaimed inductive switching test circuit & waveform



PHYSICAL DIMENSIONS

TO-220F



Symbol	Dimension (mm)			Symbol	Dimension (mm)		
	Min	Nom	Max		Min	Nom	Max
E	9.96	10.16	10.36	e	2.54(BSC)		
A	4.50	4.70	4.90	L	12.68	12.98	13.28
A1	2.34	2.54	2.74	L1	2.93	3.03	3.13
A2	0.30	0.45	0.60	ØP	3.03	3.18	3.38
A4	2.56	2.76	2.96	ØP3	3.15	3.45	3.65
c	0.40	0.50	0.65	F3	3.15	3.30	3.45
c1	1.20	1.30	1.35	G3	1.25	1.35	1.55
D	15.57	15.87	16.17	b1	1.18	1.28	1.43
H1	6.70(REF)			b2	0.70	0.80	0.95

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